

SEMITRANS[®] 3

Trench IGBT Modules

SKM600GB07E3

Features*

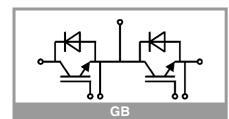
- V_{CE(sat)} with positive temperature coefficient
- High short circuit capability, self limiting to 6 x I_{cnom}
- Fast & soft switching inverse CAL diodes
- Insulated copper baseplate using DCB Technology (Direct Copper Bonding)
- · With integrated gate resistor

Typical Applications

- AC inverter drives
- UPS
- Electronic welders

Remarks

- Case temperature limited to T_c = 125°C max.
- Recommended $T_{op} = -40 \dots +150^{\circ}C$
- Product reliability results valid for T = 150°C
- for $T_j = 150^{\circ}C$ • Use of soft R_G necessary



| Absolut | te Maximum Ratin | gs | | |
|---------------------|--|-------------------------|---------|------|
| Symbol | Conditions | | Values | Unit |
| IGBT | | | | |
| V _{CES} | T _j = 25 °C | | 650 | V |
| lc | T _j = 175 °C | T _c = 25 °C | 852 | А |
| | | T _c = 80 °C | 644 | А |
| I _{Cnom} | | | 600 | A |
| I _{CRM} | I _{CRM} = 3 x I _{Cnom} | | 1800 | А |
| V _{GES} | | | -20 20 | V |
| t _{psc} | $V_{CC} = 360 V$ $V_{GE} \le 15 V$ $V_{CES} \le 650 V$ | T _j = 150 °C | 6 | μs |
| Tj | | I | -40 175 | °C |
| Inverse | diode | | | · |
| V _{RRM} | T _j = 25 °C | | 650 | V |
| I _F | T 475 00 | T _c = 25 °C | 812 | А |
| | — T _j = 175 °C | T _c = 80 °C | 595 | А |
| I _{Fnom} | | ! | 600 | А |
| I _{FRM} | I _{FRM} = 2 x I _{Fnom} | | 1200 | A |
| I _{FSM} | t _p = 10 ms, sin 180°, T _j = 25 °C | | 4320 | А |
| Tj | | | -40 175 | °C |
| Module | | | | • |
| I _{t(RMS)} | | | 500 | А |
| T _{stg} | module without TIM | | -40 125 | °C |
| V _{isol} | AC sinus 50 Hz, | t = 1 min | 4000 | V |

| Characte | eristics | | | | | |
|---|---|-----------------------------|------|-------|-------|-----|
| Symbol | Conditions | min. | typ. | max. | Unit | |
| IGBT | | | | | | |
| V _{CE(sat)} | $I_{\rm C} = 600 {\rm A}$ | T _j = 25 °C | | 1.45 | 1.90 | V |
| | V _{GE} = 15 V chiplevel | T _j = 150 °C | | 1.70 | 2.10 | V |
| V _{CE0} | chiplevel | T _j = 25 °C | | 0.90 | 1.00 | V |
| | | T _j = 150 °C | | 0.82 | 0.90 | V |
| r _{CE} V _{GE} = 15 V chiplevel | V _{GE} = 15 V | T _j = 25 °C | | 0.92 | 1.50 | mΩ |
| | chiplevel | T _j = 150 °C | | 1.47 | 2.00 | mΩ |
| V _{GE(th)} | $V_{GE}=V_{CE}$, $I_C = 9.6 \text{ mA}$ | | 5.1 | 5.8 | 6.4 | V |
| I _{CES} | $V_{GE} = 0 V, V_{CE} = 65$ | 0 V, T _j = 25 °C | | | 0.3 | mA |
| Cies | $V_{or} = 25 V$ | f = 1 MHz | | 37.0 | | nF |
| Coes | | f = 1 MHz | | 2.32 | | nF |
| C _{res} | | f = 1 MHz | | 1.10 | | nF |
| Q_{G} | V _{GE} = - 8 V+ 15 V | | | 4800 | | nC |
| R _{Gint} | T _j = 25 °C | | | 0.5 | | Ω |
| t _{d(on)} | $I_{C} = 600 \text{ A}$ $V_{GE} = +15/-7.5 \text{ V}$ $R_{G \text{ on}} = 3 \Omega$ | T _j = 150 °C | | 83 | | ns |
| t _r | | T _j = 150 °C | | 121 | | ns |
| Eon | | T _j = 150 °C | | 20 | | mJ |
| t _{d(off)} | | T _j = 150 °C | | 1100 | | ns |
| t _f | | T _j = 150 °C | | 93 | | ns |
| E _{off} | | T _j = 150 °C | | 37 | | mJ |
| R _{th(j-c)} | per IGBT | | | | 0.066 | K/W |
| R _{th(c-s)} | per IGBT (λ_{grease} =0.81 W/(m*K)) | | | 0.033 | | K/W |
| R _{th(c-s)} | per IGBT, pre-applied phase change material | | | 0.021 | | K/W |



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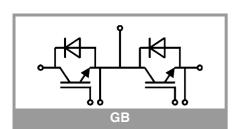
Typical Applications

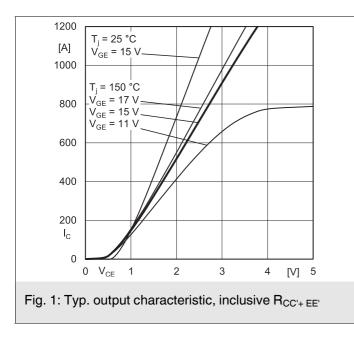
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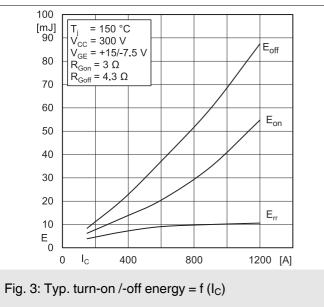
Remarks

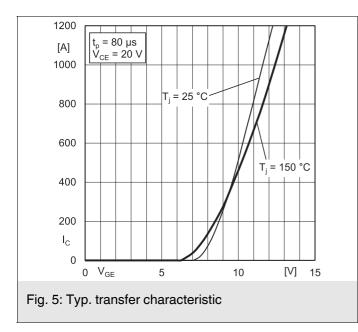
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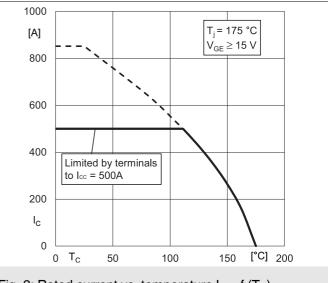
| Characte | ristics | | | | | |
|-----------------------|--|-------------------------|------|--------|-------|-----|
| Symbol | Conditions | min. | typ. | max. | Unit | |
| Inverse d | iode | | | | | |
| $V_F = V_{EC}$ | I _F = 600 A | T _j = 25 °C | | 1.40 | 1.76 | V |
| | V _{GE} = 0 V chiplevel | T _j = 150 °C | | 1.38 | 1.77 | V |
| V _{F0} | chiplevel | T _j = 25 °C | | 1.04 | 1.24 | V |
| | | T _j = 150 °C | | 0.85 | 0.99 | V |
| r _F | chiplevel | T _j = 25 °C | | 0.60 | 0.88 | mΩ |
| | | T _j = 150 °C | | 0.89 | 1.31 | mΩ |
| I _{RRM} | $I_{F} = 600 \text{ A}$ di/dt _{off} = 4940 A/µs V _{GE} = +15/-7.5 V V _{CC} = 300 V | T _j = 150 °C | | 390 | | Α |
| Q _{rr} | | T _j = 150 °C | | 54 | | μC |
| E _{rr} | | T _j = 150 °C | | 9.1 | | mJ |
| R _{th(j-c)} | per diode | | | | 0.096 | K/W |
| R _{th(c-s)} | per diode (λ _{grease} =0.81 W/(m*K)) | | | 0.038 | | K/W |
| R _{th(c-s)} | per diode, pre-applied phase change material | | | 0.028 | | K/W |
| Module | | | | | | |
| L _{CE} | | | | 15 | | nH |
| R _{CC'+EE'} | measured per switch | T _C = 25 °C | | 0.55 | | mΩ |
| | | T _C = 125 °C | | 0.85 | | mΩ |
| R _{th(c-s)1} | calculated without thermal coupling (λ _{grease} =0.81 W/(m*K)) | | | 0.0088 | | K/W |
| R _{th(c-s)2} | including thermal coupling, T _s underneath module $(\lambda_{grease}=0.81 \text{ W/(m^{*}K)})$ | | | 0.014 | | K/W |
| R _{th(c-s)2} | including thermal coupling, T _s underneath module, pre-applied phase change material | | | 0.010 | | K/W |
| Ms | to heat sink M6 | | 3 | | 5 | Nm |
| M _t | | to terminals M6 | 2.5 | | 5 | Nm |
| | 1 | | | | | Nm |
| w | | | | | 325 | g |

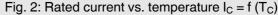


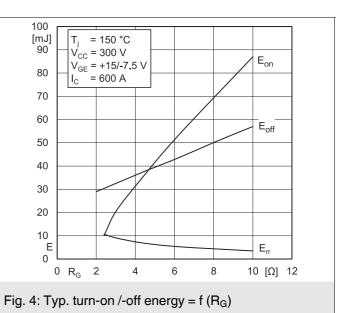


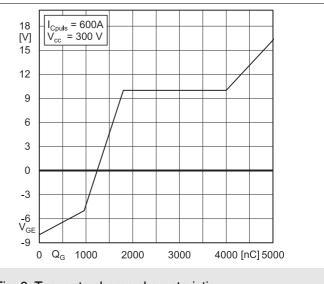


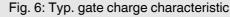


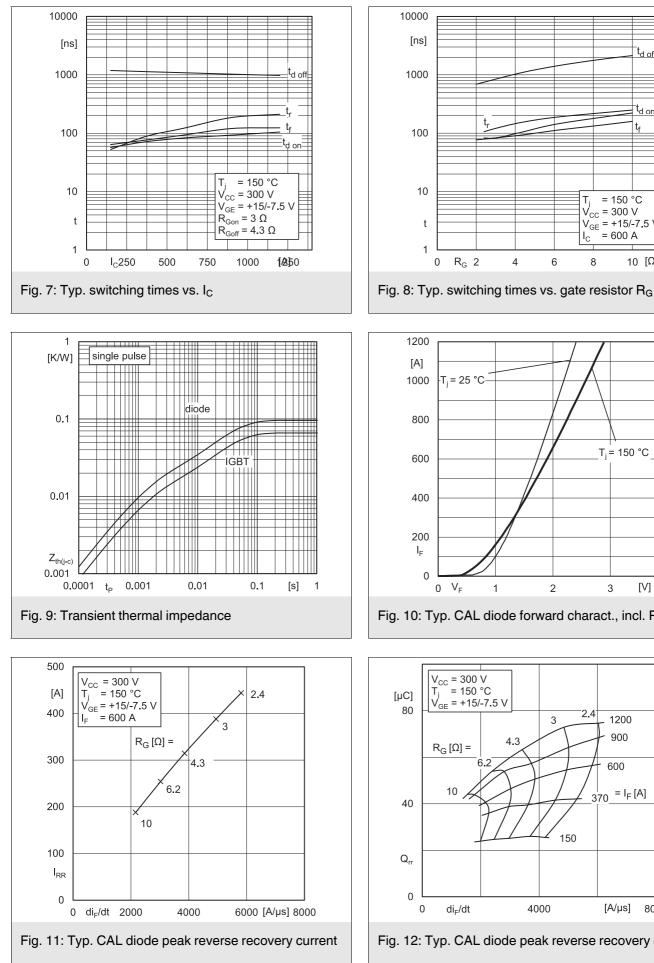


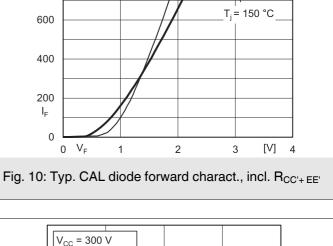












2.4

3

1200

⁻t_{d off}

t_{d on}

10 [Ω] 12

tf

= 150 °C

 $V_{GE} = +15/-7.5 V$ $I_C = 600 A$

 $V_{\rm CC} = 300 \, \rm V$

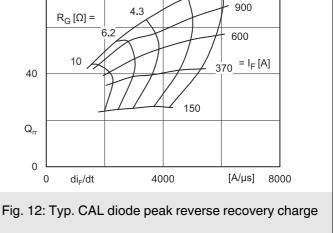
T_i

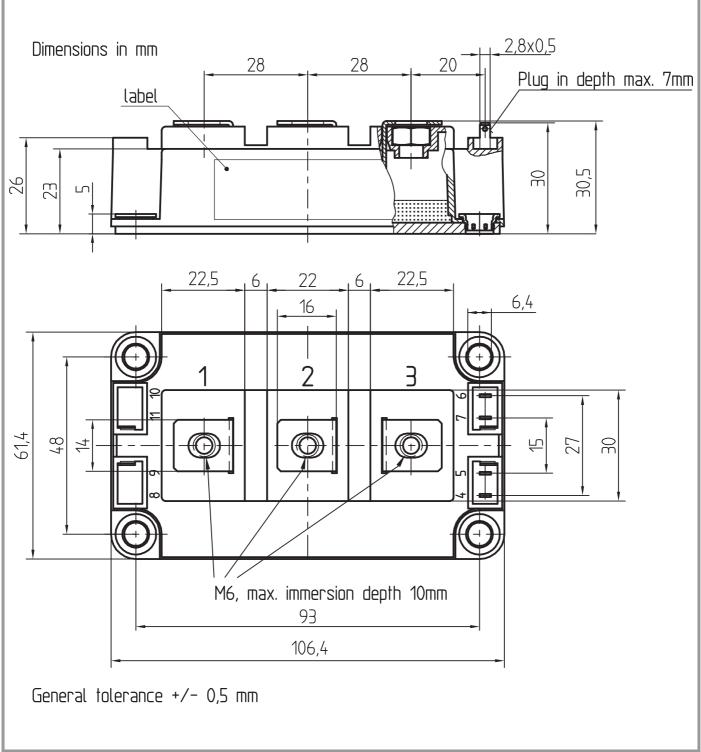
 I_{C}

8

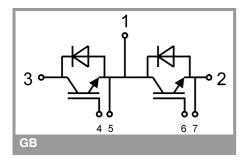
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4









Rev. 4.0 – 29.05.2020

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

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